I. INTRODUCTION

A. Motivation

There are many natural and engineering systems that exhibit pattern formation and are defined on periodic spatial or time domains: some examples are coupled oscillators [1], oscillatory convection in binary mixtures [2], numerous astrophysical phenomena [3–6], synchronous rhythmic flashing of fireflies [7], along-the-edge instabilities of accelerating liquid sheets [8], and crown patterns in the drop splash phenomena [9], just to name a few. In this work, we consider systems in which patterns are formed due to instabilities with several wave numbers excited at the same growth rate. One recent example refers to along-the-edge instability of liquid sheets [8,10,11], where it was found that the linear evolution of the interfacial perturbation \( f \) (or its Fourier coefficient \( f_{k,n}, k \in \mathbb{R} \) and \( n \in \mathbb{Z} \)), is governed by the following dispersion relation:

\[
\lambda^2 = -\kappa(\sigma^{-1}k^2 + 1),
\]

where \( \lambda \) is the growth rate, \( \kappa = \pm \sqrt{n^2 + k^2} \) is the two-dimensional wave number, and \( \sigma \) is the bifurcation parameter. Since the growth rate \( \lambda \) depends only on the modulus of the two-dimensional wave number \( \kappa \), the maximum growth rate \( \lambda_{\text{max}} \) is achieved at \( \kappa_{\text{max}} = \sqrt{\sigma^2 + 1} \), and thus if \( \kappa_{\text{max}} > n > 1 \), there exists several critical wave numbers \( k^{(i)}_c \), parametrized by \( i = 0, \ldots, n \), with the same growth rate \( \lambda_{\text{max}} \).

At the linear level, the above result implies that if only one critical wave number is excited, then the pattern is single-wave-number, while for higher values of \( \sigma \), more than one critical wave number can be excited such that the picture becomes “frustrated,” cf. Fig. 1(b), as was discovered recently in certain regimes of the drop splash phenomenon [9]. The frustrated picture occurs due to the randomness of the initial conditions, which are amplified and evolved into several superimposed single-wave-number patterns of different wave numbers and with random phase shifts between them.
limited data, e.g., only the peaks of patterns, which, as we will show, are nevertheless sufficient to determine the pattern structure.

C. Paper outline

In Sec. II, we first discuss the currently available tools and show their inapplicability to the resolution of the key problem formulated above. Next, we develop a theory (Sec. III) that shows under which conditions patterns are identifiable in the ideal case (Sec. III B), in the presence of scatter (Sec. III C), as well as for the data with overlaps (Sec. III D) and missing points (Sec. III E). As an example of an application of the developed theory, we use the data from the crown patterns in the drop splash problem (Sec. IV), which required a new experimental technique (Sec. IV A) to obtain data suitable for the analysis presented here. The examples of data analysis are given in Sec. IV B. The discussion is concluded in Sec. V with questions requiring further exploration.

II. INAPPLICABILITY OF KNOWN APPROACHES

In the case of a simple periodic signal, one may use finite differences $\Delta \theta_{ij} = \theta_i - \theta_j$ to identify if such a pattern is periodic with a single period because the first off-diagonal elements of the matrix $\Delta \theta_{ij}$ give the period. For example, for

$$\Theta = \{0, \pi/2, \pi, 3\pi/2\}, \tag{2}$$

this matrix becomes

$$\Delta \theta_{ij} = \begin{pmatrix} 0 & -\frac{\pi}{2} & -\pi & -\frac{3\pi}{2} \\ \frac{\pi}{2} & 0 & -\frac{\pi}{2} & -\pi \\ \pi & \frac{\pi}{2} & 0 & -\frac{\pi}{2} \\ 3\pi/2 & \pi & \frac{\pi}{2} & 0 \end{pmatrix}, \tag{3}$$

which tells us that the period is $\pi/2$. However, once multiple periods are present, one must account for “interference,” and thus finite differences alone become insufficient and inefficient. In the case of a substantial number of data points, a “guess work” search for patterns is not feasible either because of the large number of possible combinations to analyze. Besides these direct inefficient approaches, one may also think of application of the DFT, circular statistics, and the order parameter method to gain some insight into the pattern structure; however, as will be shown below, they do not allow one to resolve the key problem adequately and robustly.

A. Discrete Fourier transform

While the DFT is the standard tool for wave-number or frequency analysis, it works well only for the data obeying the Nyquist-Shannon sampling theorem. For example, given the set (2) representing only the spike location, so that the corresponding points on the unit circle are

$$x_n = e^{i \theta_n}, \quad n = 0, \ldots, N - 1, \tag{4}$$

the DFT

$$X_k = \sum_{n=0}^{N-1} x_n e^{-(2\pi i/N)k n}, \quad k = 0, \ldots, N - 1, \tag{5}$$

gives $X = \{0,4,0,0\}$, i.e., the wave number $k = 1$ (corresponding to the wavelength $2\pi$) is identified instead of the correct one $k = 4$. The same Fourier amplitudes $X$ are obtained for the very different data set $\Theta = \{\pi/2, \pi/2, \pi/2, \pi/2\}$.

Also, if we superimpose on the top of (2) the same wave-number pattern (2) but with a phase shift $\phi = \pi/12$, then the DFT yields the distribution of the Fourier amplitudes as in Fig. 2(b), which clearly illustrates that for a given set of data, the DFT does not help one to identify readily that there are two single-wave-number patterns with $k = 4$ and the phase shift $\phi = \pi/12$. Instead, one may formally conclude that the pattern is of the wave number $k = 2$ with some noise. The useful insight one can get from the above examples is that the maximum of the power spectrum (in the ideal case without scatter) shown in Fig. 2(b) is approximately equal to the number of pattern data points. For example, in the considered example it is equal to 7.93 $\pm$ 8, but there are a number of possible combinations of wave numbers yielding the same maximum of the power spectrum. The number of possible subpattern combinations grows with the number of data points and thus makes the DFT approach nonconstructive. Therefore, one needs a robust and systematic approach to decompose and identify patterns.

B. Circular statistics and order parameter

There are many systems, defined on a circle, that include problems with angles and time and require statistical analysis known as circular statistics [13]. One example from circular statistics is the measurement of the angles at which birds take flight [14]. Biologists are interested in how the data are clumped, i.e., if the birds leave in the same direction.
Therefore, the circular statistics analysis is not intrinsically targeted to the identification and quantification of regular patterns because a regular distribution of the birds’ departure angles would involve some sophisticated bird behavior.

More precisely, given a set of angles on the interval \([0, 2\pi]\), each of them defines a unit vector—adding up all these unit vectors results in a vector of length \(r\), which can be rephrased more compactly using complex exponentials,

\[
r(m)e^{i\phi(m)} = \frac{1}{N} \sum_{j=1}^{N} e^{i\theta_j m}, \quad m \in \mathbb{N},
\]

where in the case \(m = 1\) the expression \(re^{i\phi}\) is known as the trigonometric moment in circular statistics [13], and the complex order parameter in dynamical systems [1,15]. Essentially, the complex order parameter can be interpreted as the collective rhythm produced by the collection of points on the unit circle in the complex plane. The complex order parameter is a useful diagnostic tool but its scope is to give a sense of how well ordered the system is: if \(r(1) \simeq 0\), then the system is considered disordered as the unit vectors point in arbitrary uniformly distributed directions; if, on the other hand, \(r(1) \simeq 1\), then the azimuths of a distribution are clumped in a particular direction. This is also known as the Rayleigh test. From the perspective of our analysis of patterns, when the order parameter is small, as in the case of regular pattern data with some scatter, then there is formally no difference between random and regular data from the point of view of circular statistics. The general case of (6), \(m \geq 1\), introduced by Daido [16], allows one to characterize the synchronization properties and clustering: \(r(m)e^{i\phi(m)}\) are the \(m\)th Fourier modes of the distribution of phases. While the usual Kuramoto order parameter \(r(1)e^{i\phi(1)}\) [15] is suitable for distributions with a single maximum, the higher-order parameters are suitable for analyzing distributions with several maxima, often referred to as clusters. However, as we will show in Sec. IV, even such a generalization is not suitable for the identification of patterns composed of several single-wave-number patterns with random phase shifts between them.

III. PATTERN IDENTIFICATION THEORY

A. Key notions

We begin by first introducing the key notions informally as motivated by the examples discussed in Secs. I and II. A single-wave-number pattern is a set of elements that are regularly spaced on a circle and have at least two elements, e.g., (2). A regular pattern is a set consisting of a finite union\(^2\) of single-wave-number patterns with (potentially random) phase shifts between them, cf. Fig. 2(a). As a result, an irregular pattern does not have a regular structure and cannot be decomposed into a union of single-wave-number patterns.

For systems with \(S(1)\) symmetry, it is natural to consider a data point as an angle \(\theta \in [0, 2\pi]\), where the angles 0 and \(2\pi\) are understood to represent the same point. A single-wave-number pattern is described by a wave number \(k \geq 2\) and a phase \(\phi\) with respect to the origin \(\theta = 0\), as illustrated in Fig. 3. Positive angles are measured in the counterclockwise direction from the \(x\) axis. The spacing between two consecutive elements of a single-wave-number pattern is called the wavelength \(\lambda\) and is related to the wave number by \(k = 2\pi/\lambda\), which is an integer and also represents the number of points (spikes) on the unit circle.

If a single-wave-number pattern with wave number \(k\) contains \(k\) elements, it is said to be complete, i.e., not missing any elements. Expressing a regular pattern in terms of single-wave-number patterns constitutes pattern decomposition.

B. Regular ideal patterns

We begin with the simplest case—the “ideal pattern”—which is considered to be free from experimental scatter. The ideal-pattern case will serve as the basis for more general cases developed later in Secs. III C–III E.

1. Definitions

For the purpose of qualitative analysis, we will need a formal definition of ideal patterns.

Definition 1. Ideal single-wave-number pattern. Let \(\Theta = \{\theta_1, \ldots, \theta_k\}\) be a set of \(\infty \geq k \geq 2\) elements. If \(\Theta\) can be represented as

\[
\{\theta_n \in [0, 2\pi) \mid \theta_n = n\lambda + \phi, \quad \text{for} \ n = 0, \ldots, k - 1\},
\]

where \(\lambda = 2\pi/k\) is the wavelength and \(\phi \in [0, \lambda)\) the phase shift, then \(\Theta(k, \phi)\) is an ideal single-wave-number pattern.

An ideal regular pattern is a set that can be decomposed into a finite union of ideal single-wave-number patterns, as formalized below.

Definition 2. Ideal regular pattern. Let \(\Theta\) be a finite set containing all elements of interest. If \(\Theta = \bigcup_{j=1}^{m} \Theta^{(j)}(k_j, \phi_j)\), where \(\Theta^{(j)}\) is the \(j\)th ideal single-wave-number pattern such that \(\Theta^{(i)} \cap \Theta^{(j)} = \emptyset\) if \(i \neq j\), and \(m\) is the least number

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\(^2\)Since the goal here is to develop practical algorithms, we consider a finite union of single-wave-number patterns because, from an experimental point of view, an infinite union would be indistinguishable from continuous data. From a theoretical point of view, one can consider an infinite union of single-wave-number patterns, and the resulting pattern would still be formally identifiable with the algorithms presented in the paper.
of ideal single-wave-number patterns, then $\Theta$ is an ideal regular pattern.

Note that permutations in this decomposition into single-wave-number patterns do not lead to a new pattern. To clarify the terminology introduced above, consider the example in Fig. 3. Plotted are the angles from the set $\Theta = \{\phi, \pi/2 + \phi, \pi + \phi, 3\pi/2 + \phi\}$ with $\phi = \pi/6$. By inspection, we see that this set is a single-wave-number pattern with the wave number $k = 4$ and the wavelength $\lambda = \pi/2$ because $\Theta \equiv \Theta(4, \phi) = \{\theta_i \in [0, 2\pi) \mid \theta = \pi n/2 + \phi \text{ for } n = 0, \ldots, 3\}$.

For the subsequent analysis, we will also need the difference matrix introduced in Sec. II, which is a key step toward uncovering the regular decomposition of a set $\Theta = \{\theta_1, \ldots, \theta_N\}$ with $N$ elements. The difference $N \times N$ skew-symmetric matrix $\Delta \Theta$ consists of differences between all pairs of elements in the set $\Theta$:

$$\Delta \Theta_{ij} = \theta_i - \theta_j. \quad (8)$$

**Remark.** The difference matrix $\Delta \Theta$ contains $(N - 1)N/2 = \begin{pmatrix} N \\ 2 \end{pmatrix}$ possible unique entries; its lower triangular half of $\Delta \Theta$ contains all the positive difference combinations, cf. (3).

### 2. Pattern identification

Now the idea is to demonstrate decomposability of ideal regular patterns.

**Theorem 1.** If a given ideal regular pattern is complete and without overlapping elements, then there exists an algorithm that identifies it. The resulting pattern decomposition is unique.

**Proof.** Let us demonstrate the existence of at least one algorithm capable of decomposing any given ideal regular pattern, which is complete and without overlaps, into ideal single-wave-number patterns with some phase shifts between them. In order to initiate a decomposition of the given set $\Theta = \{\theta_1, \ldots, \theta_N\}$ with $N$ elements, we should expect to find $\Theta = \Theta(3, 2\pi/3)$.

We now clarify these ideas with an example. Refer to Fig. 4, where $\Theta(6, 0) = \{\theta_i \in [0, 2\pi) \mid \theta = \pi n/3 \text{ for } n = 0, \ldots, 5\}$, we can observe that this single-wave-number pattern with wave number 6 can be grouped into two sets of single-wave-number patterns with wave number 3, or into three sets of single-wave-number patterns with wave number 2:

$$\Theta(6, 0) = \Theta^{(1)}(3, 0) \cup \Theta^{(2)}(3, \pi/3), \quad (11a)$$

$$= \Theta^{(3)}(2, 0) \cup \Theta^{(4)}(2, \pi/3) \cup \Theta^{(5)}(2, 2\pi/3). \quad (11b)$$

**3. Subpatterns of single-wave-number patterns**

In certain cases, a single-wave-number pattern may be decomposed as a union of smaller subpatterns. A subpattern is simply another single-wave-number pattern with a smaller wave number (larger wavelength), which is a subset of the larger single-wave-number pattern under consideration. This idea of subpatterns will prove useful when analyzing patterns with overlaps in Sec. III D.

We now clarify these ideas with an example. Referring to Fig. 4, where $\Theta(6, 0) = \{\theta_i \in [0, 2\pi) \mid \theta = \pi n/3 \text{ for } n = 0, \ldots, 5\}$, we can observe that this single-wave-number pattern with wave number 6 can be grouped into two sets of single-wave-number patterns with wave number 3, or into three sets of single-wave-number patterns with wave number 2:

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$$= \Theta^{(3)}(2, 0) \cup \Theta^{(4)}(2, \pi/3) \cup \Theta^{(5)}(2, 2\pi/3). \quad (11b)$$

**FIG. 4.** An ideal single-wave-number pattern $\Theta(6, 0)$.  

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3Otherwise, as is easy to conclude, the decomposition of an ideal regular pattern into ideal single-wave-number patterns is not unique.
In general, this leads to the following claim, the proof of which is straightforward.

**Lemma 1.** Any ideal single-wave-number pattern $\Theta(N, \phi)$, where $N$ is not a prime number, may be expressed as a union of ideal single-wave-number patterns of wave number $p$, where $p$ is an integer divisor of $N$,

$$\Theta(N, \phi) = \bigcup_{i=1}^{N/p} \Theta^{(i)}(p, \phi + \lambda N(i - 1)). \quad (12)$$

**C. Regular patterns with scatter**

A natural generalization of ideal patterns is to consider the case of (nonideal) regular patterns when the elements of $\Theta$ have some uncertainty (experimental scatter) associated with them. As such, the following development is more relevant to actual measured data. It is natural to introduce nonideal patterns by allowing deviations (residuals) from the ideal case. Hence, a regular pattern with scatter is defined about the corresponding ideal regular pattern by letting $\epsilon_i$ be the deviation of $\theta_i$ from the ideal case. A natural assumption is that the magnitude of the uncertainties $|\epsilon_i|$ is bounded from above by some constant $\delta$. Such patterns are called regular with scatter, where the amount of scatter is quantified with the scatter bound $\delta$.

**Definition 3.** Single-wave-number pattern with scatter. Let $\Theta = \{\theta_1, \ldots, \theta_k\}$ be a set with $k$ elements. If $\Theta$ admits the representation $\{\theta_n \in [0, 2\pi) | \theta_n = n\lambda + \phi + \epsilon_n, n = 0, \ldots, k - 1, |\epsilon_n| \leq \delta\}$, where $\lambda = 2\pi/k$ is the wavelength, $\phi \in [0, \lambda)$ is the phase shift, and $\delta$ is the scatter, then $\Theta(k, \phi, \delta)$ is a single-wave-number pattern with scatter.

Figure 5 illustrates the correspondence between the two ways of viewing the same pattern. On the left is the unit circle with points $\theta_i$ shifted by $\epsilon_i$ from the ideal location. On the right is a plot in the $(n, \theta_n)$ coordinates. All the points collapse to a line in the limit of vanishing scatter $\delta \rightarrow 0$. This graphical representation of a regular pattern naturally illustrates scatter and phase shifts, e.g., the phase shift is just the y intercept of the line. One can apply standard error analysis [17] by considering $\Theta = \{\theta_1, \ldots, \theta_N\}$ as a series of measurements, which ideally should fall on a line $\theta_n = \lambda n + \phi$, where $\lambda = 2\pi/k$ and $k \in \mathbb{N}$ [cf. Fig. 5(b)].

As is easy to see, the condition for a given pattern to be in the ideal regime is when two elements are not closer than twice the scatter $\delta$, $\lambda > 2\delta$. Such spacing of the elements allows one to avoid the ambiguity when two points lie within the scatter radius and effectively overlap. From a theoretical perspective, the two conditions—spacing of the elements and the pattern completeness—are sufficient to avoid the cases when patterns are not identifiable.

**Theorem 2.** If a given regular pattern $\Theta$ with scatter $\delta$ is complete and in the ideal regime, such that neither of the two elements of $\Theta$ are closer than twice the scatter, $\lambda > 2\delta$, then there exists an algorithm that identifies the pattern. The resulting pattern decomposition is unique.

**Proof.** We will again demonstrate the existence of an algorithm that identifies regular patterns with scatter by providing the decomposition into single-wave-number patterns with scatter. Let $\Theta$ be a regular pattern with $N$ elements that can be partitioned into single-wave-number patterns with scatter $\delta$. In the ideal regime, the single-wave-number patterns are separated such that $\Theta(i) \cap \Theta(j) = \emptyset$ if $i \neq j$. Similar to the case without scatter, we begin by considering a difference between two elements of $\Theta$,

$$\Delta \Theta_{ij} = (n_i \lambda + \phi_n + \epsilon_n) - (n_j \lambda' + \phi_{n'} + \epsilon_{n'}), \quad (13)$$

for some indices $n_i, n_j \in \mathbb{Z}^+$. In analogy to the ideal case considered in Sec. III B, Eq. (13) may be simplified if $\theta_i$ and $\theta_j$ belong to the same single-wave-number pattern with scatter. That is, $\theta_i, \theta_j \in \Theta(k)$,

$$\Delta \Theta_{ij} = (n_i - n_j) \lambda + \epsilon_n - \epsilon_{n'}. \quad (14)$$

By the theorem assumption, $\epsilon_n, \epsilon_{n'}$ are both bounded by constant $\delta$, so that the relation (14) gives

$$|\Delta \Theta_{ij} - (n_i - n_j) \lambda| \leq 2\delta. \quad (15)$$

Equation (15) is an exact analogy to Eq. (10) in the ideal case, with the only difference being that the scatter parameter $\delta$ introduces an inequality [the ideal equality case (10) is recovered in the limit $\delta \rightarrow 0$]. Thus, the algorithm follows that of Theorem 1 and therefore provides a unique pattern decomposition (provided $\lambda > 2\delta$).

Therefore, in the regular pattern regime with scatter, the analysis is straightforward and no “pathological” cases need be considered because the points are spaced according to the conditions in Theorem 2. With the modification of the equality (10) to the inequality (15), the algorithm is identical to the one presented for ideal regular patterns in Sec. III B.

**D. Regular patterns with overlaps**

Until now, we have considered only regular patterns when no overlapping single-wave-number patterns may occur. Figure 6 illustrates an ideal regular pattern with overlaps when no overlapping single-wave-number patterns may occur. Therefore, in the regular pattern regime with scatter, the analysis is straightforward and no “pathological” cases need be considered because the points are spaced according to the conditions in Theorem 2. With the modification of the equality (10) to the inequality (15), the algorithm is identical to the one presented for ideal regular patterns in Sec. III B.
single-wave-number patterns. The presence of overlaps in a regular pattern requires the understanding of the origin of single-wave-number patterns developed in Sec. III B, as will become clear from the subsequent discussion.

Motivated by the example in Fig. 6, let us consider ideal regular patterns, which may contain overlapping ideal single-wave-number patterns, while each component single-wave-number pattern is complete.

**Theorem 3.** If a given ideal regular pattern, possibly containing overlaps, consists of complete single-wave-number patterns, then there exists an algorithm that identifies it. The resulting pattern decomposition is unique.

**Proof.** Let us again demonstrate the existence of an algorithm that identifies ideal regular patterns potentially containing ideal single-wave-number patterns with overlaps. Accommodating the presence of overlaps requires only a few modifications of the original algorithm developed in Sec. III B. The main modification is to note that a given element $t_i \in \Theta$ may belong to multiple single-wave-number patterns. Therefore, subtracting single-wave-number patterns as they are identified may affect other equally valid single-wave-number patterns. One mechanism to avoid this complication is to test for and identify all possible single-wave-number patterns with wave numbers ranging from $N$ to 2 without removing single-wave-number patterns once they are identified. From Lemma 1 on subpatterns, finding redundant subpatterns of a single-wave-number pattern is trivial and guarantees a unique pattern decomposition. Once subpatterns are removed, all that remains are the largest possible single-wave-number patterns, which constitute the decomposition of the ideal regular pattern. The rest of the algorithm is the same as in Theorem 1. }

**E. Incomplete patterns**

Finally, we provide some considerations for the case of incomplete regular patterns, i.e., when there are missing points, which can be due, for example, to the limited ability to collect experimental data. These considerations lead to a proper definition of incomplete patterns and the conditions under which they are identifiable. It is not straightforward, however, to define an incomplete pattern because any given regular pattern can be considered to be the result of a larger pattern missing the appropriate elements. We illustrate this and other complexities with the following simple example of a regular single-wave-number pattern $\Theta^R(4,\phi)$ in Fig. 7(a). Let us remove some elements and consider whether the resulting incomplete pattern is identifiable. To identify an incomplete pattern, a minimal number of elements are added such that a regular pattern is completed.

In the first case, when only one element is removed, as shown in Fig. 7(b), the incomplete pattern is identifiable and can be completed because the grayed element can be added by extrapolating the obvious wavelength $\pi/2$ to the area of missing spikes.

The second case deals with two elements, which can be removed in two ways. Figure 7(c) shows the result if two consecutive elements are removed. In this case, the incomplete pattern may be identified in the manner analogous to the one in Fig. 7(b) since the wavelength is identifiable: the two grayed elements may be added back to make a single-wave-number pattern with wave number 4. In the other case, in which two nonadjacent elements are removed as in Fig. 7(d), the “incomplete” pattern is just a single-wave-number pattern with wave number 2. Therefore, the incomplete pattern is not identifiable. The key distinction in this case from the former ones is that the removed elements constitute a subpattern, which is a single-wave-number pattern on its own.

Therefore, a useful definition of an incomplete pattern is the one in which a pattern is identifiable. **Definition 4.** An incomplete regular pattern $\Theta^I$ is a regular pattern, $\Theta^R$, minus a subset of points $\Theta^- \subset \Theta^R$:

$$\Theta^I(k,\phi) = \Theta^R(k,\phi) \setminus \Theta^-,$$  \hfill (16)

where $\Theta^I$ is not a regular pattern in the sense of Definition 2.

While the theory of incomplete pattern identification has yet to be developed, probably in the context of a concrete
application, one may conjecture that a sufficient condition for \( \Theta^J(k, \phi) \) to be identifiable is if \( \Theta^- \) is not regular, i.e., not decomposable into any single-wave-number patterns.

IV. APPLICATION: CROWN PATTERNS IN THE DROP SPLASH PROBLEM

The goal of this section is to provide an illustration of physical phenomena when the question of pattern identification arises and to demonstrate an experimental approach to obtaining data suitable for the analysis offered in Sec. III. The illustration comes from the drop splash problem [9]. Since the goal here is just to illustrate pattern identification theory, no attempt is made to perform a full study of the drop splash patterns, which is beyond the scope of the present paper.

A. Experimental setup and data extraction

The key components of the experimental setup (cf. Fig. 8) necessary to collect the data suitable for the pattern identification analysis can be divided into two groups. The first group is responsible for measuring the physical parameters and generating the drop splash, which is discussed in detail in [9]. Namely, the droplet is created by pumping a liquid through a syringe at a consistent low flow rate, ensuring that droplet formation is uniform. The syringe is positioned, with the help of a linear stepper motor, above a petri dish filled with a thin liquid film of controlled thickness.

The second group of components serves to capture the drop splash event. Since the drop splash event lasts over a fraction of a second, high-speed cameras (Phantom v5.1-5.2) are necessary to capture the dynamics, which is standard in the drop splash studies. However, since we are interested in the structure of the crown in space, we use three-dimensional (3D) high-speed photography, which is new in the context of drop splash studies. However, since we are interested in the structure of the crown in space, we use three-dimensional (3D) high-speed photography, which is new in the context of drop splash studies. Not that it is impossible to get accurate positions of the crown spikes using just one camera because (a) it cannot be placed right above the drop splash and (b) the time-dependent dynamics of the crown is unknown. The setup in Fig. 8 illustrates how two high-speed cameras are positioned at two different viewing angles to generate a stereo video of the event. The cameras need to be calibrated and synchronized with a trigger to ensure that each pair of frames corresponds to the same time event.

![FIG. 8. Schematic of the experimental setup consisting of two synchronized high-speed cameras (HSC) oriented at different viewing angles.](image)

B. Stereo camera calibration and triangulation

The basic idea of the stereo approach is that given two images of the same scene taken from different viewing positions, they are first matched and the difference between them allows one to recover the lost 3D dimension, i.e., the depth [18].

The practice of making physical measurements using images, known as photogrammetry, is over a century old; the historical development of camera models and calibration techniques may be found in [19]. The result of a “camera calibration” is a model of the camera that translates between a point in an image and the light ray that is projected to that point, which is indispensable for relating the image features acquired with stereo photography to the laboratory coordinates. A stereo calibration consists of determining the position of the right camera reference frame with respect to the left camera (or vice versa). Beginning with the seminal work by Tsai [20], steady progress has been made toward the passive calibration of standard cameras [21,22], which does not require any internal information about the camera, such as its focal length. Bouguet [23] has implemented the calibration procedure into a MATLAB toolbox [24], which is used in our setup.

Stereo triangulation, i.e., the determination of a coordinate in 3D space from a pair of images, is possible once a stereo calibration has been performed. Stereo triangulation makes use of the fact that each pixel location on the image defines a ray as in human vision, hence determining a point in 3D space becomes a geometric problem of finding the point of intersection of two rays (or the closest point between the rays in the nonideal case). Accuracies of various calibration routines, when an object of known geometry is compared to the geometry measured using a stereo triangulation method, have been reported to be one part in a thousand [20].

2. Data extraction procedure

We now give a detailed description of the data extraction procedure, which begins with a pair of images and ends with a set of angles \( \Theta \).

The first step is to identify the corresponding spikes in each of the left and right images. The corresponding spikes from the left and right images are shown in Fig. 9, where the same numbers correspond to the same spike. It should be noted that the ability to recognize the same object from different perspectives is known as the “correspondence problem” of stereo vision [25], which is complicated by noise, obstructions, and reflective properties of the viewed objects; this remains a generally unsolved problem. Therefore, the process of actually determining which spikes correspond between the left and right images is done “by hand.” For accurate correspondence, it is necessary to have a visible and identifiable point on the object in both camera views. For the purposes of the present experiment, such a point is the tip of a particular spike. We intentionally used slightly out-of-focus photos as it does not affect the accuracy of stereo triangulation.

4 For illustration, we chose to use images from later (nonlinear) stages of the drop splash evolution, which does not affect the application of the pattern identification method.
The two pixel coordinate pairs, \((\tilde{x}_l, \tilde{y}_l)\) and \((\tilde{x}_r, \tilde{y}_r)\), of a given point from the left and right cameras, respectively, are the input for the stereo triangulation function. The latter gives the position \((x_l, y_l, z_l)\) of the point in the reference frame of the left camera, cf. Fig. 10(a); the details of stereo triangulation may be found in [23].

With the 3D data now available, the next step is to reduce the data to a set of angles on the unit circle. Since the point \((x_l, y_l, z_l)\) is given in the frame of the left camera, whose position relative to the location of the crown rim is arbitrary, an ideal (flat) rim would be just a set of points lying on a circle that has been rotated and translated. Therefore, instead of directly fitting the spike coordinates to a general rotated and translated circle in 3D space, we break up the task into two linear steps: fitting to a plane and then to a circle in that plane.

A plane is fitted to the data in the least-squares sense, which gives a plane defined by its normal \(\mathbf{z}'\) vector. To rotate this plane to the laboratory frame of reference defined by normal \(\mathbf{Z}\) to the horizontal plane, we make use of Rodrigues’ rotation formula [26]. The direction of a desired rotation is from \(\mathbf{Z}\) to \(\mathbf{z}'\), i.e., a rotation vector can be found according to the right-hand rule:

\[
\mathbf{v}_{\text{rot}} = \mathbf{Z} \times \mathbf{z}'
\]

The angle of rotation is \(\theta_{\text{rot}} = \arccos (\mathbf{Z} \cdot \mathbf{z}')\), where \((\mathbf{Z} \cdot \mathbf{z}')\) is the dot product between \(\mathbf{Z}\) and \(\mathbf{z}'\). The result of implementing Rodrigues’ formula is a rotation matrix \(R\), such that \((X, Y, Z)^T = R (x_l, y_l, z_l)^T\); the projection onto the plane is obtained by setting \(Z = 0\), cf. Fig. 10(b).

The resulting set of coordinates \((X, Y)\) has to be fitted to a circle, again in the least-squares sense, which may be displaced from the origin. If the fitted circle has a center \((X_c, Y_c)\), by taking \((X, Y) \rightarrow (X - X_c, Y - Y_c)\), the center of the circle can be made to coincide with the origin of the axes. Then each data
point projected on the plane represents the point closest to the circle. Once all these steps are accomplished, determining the angle set $\theta$ becomes straightforward.

For example, given the stereo images in Fig. 9, the results of the data extraction are shown in Fig. 10. Stereo triangulation in the frame of reference of the left camera yields the position of spikes as displayed in Fig. 10(a). After fitting to a plane and rotation to the laboratory frame of reference (not shown), one can see that the variance in the Z direction is much less than the crown size in the $(X,Y)$ plane. This fact confirms the expectation that the tips of the spikes of the crown are nearly coplanar. The next step is to fit the data to a circle using the least-squares approach, the result of which is given in Fig. 10(b).

3. Remarks

As in any experiments, the collected data are subject to experimental errors and uncertainties, which can be divided into two categories. The first type of error is due to instrumentation imprecision. The second type of error comes from data reduction and analysis. For example, the error in determining the pixel coordinates of corresponding spikes is due to how well the same spike location can be identified in each image. All three factors—spike definition, camera focus, and resolution—contribute to the uncertainty in data reduction.

B. Examples of data analysis

In this section, we demonstrate the analysis of three data sets from the drop splash experiments. The three patterns we have chosen are aimed at illustrating a regular pattern, which has a substantial scatter but is still identifiable, an irregular pattern, and a frustrated pattern exemplified in Fig. 1(b); these are the cases of real experimental data that are most interesting from the point of view of the analysis presented here.

C. A regular pattern with substantial scatter

The generalized complex order parameter (6), while suggesting some clustering of data, shows the lack of a clear single dominating order between the dominant values $m = 21, 22, 23$. Therefore, the order parameter plot is inconclusive but still may be interpreted as indicating the possible presence of a single-wave-number pattern with considerable scatter.

Following the algorithm developed in the proof of Theorem 2, we arrive at the graph $\theta_n$ in Fig. 11(b), which clearly suggests that the pattern is complete with single-wave number $k = 23$ and scatter $\delta \simeq 0.94 \lambda$. The substantial scatter ratio $\delta/\lambda$ so close to unity (compare to the conditions in Theorem 2) indicates that, while it conforms with the Definition 3.

5Regular patterns with a small amount of scatter are frequently observed [cf. Fig. 1(a)], but they are not interesting to the present discussion.
of a single-wave number with scatter, the fit is far from ideal according to Theorem 2. The fact that the pattern is irregular of a single-wave number with scatter, the fit is far from ideal according to Theorem 2. The fact that the pattern is irregular

FIG. 13. (Color online) Example of data analysis in the case of the irregular pattern shown in Fig. 12: (a) moments of the complex order parameter \( r(m) \) for the function in Fig. 12; (b) extracted angles (dots) and the least-squares fit (line) according to (7) with \( \lambda = 2\pi/k \), \( k \in \mathbb{N} \); (c) residuals of the least-squares fit in (b).

D. An irregular pattern

Now let us consider the apparently irregular crown pattern shown in Fig. 12. From this figure, we may expect that interpreting the data as a complete single-wave-number pattern with some scatter is inappropriate. It is notable that the complex order parameter amplitudes in Fig. 13(a) do not suggest any dominate wave number(s). With the assumption that there are no overlaps and missing points, based on the algorithm developed in the proof of Theorem 2, one concludes that the pattern is irregular. The latter fact is also evidenced by FIG. 14. (Color online) Decomposition of the crown pattern in Fig. 1(b) into single-wave-number patterns. (a) Extracted angles (dots) and the least-squares fit (line) according to (7) with \( \lambda = 2\pi/k \), \( k \in \mathbb{N} \), the slope of which gives the wavelength of each single-wave-number pattern: \( k = 8 \) (dotted), \( k = 5 \) (dashed), \( k = 3 \) (dotted-dashed), and three patterns with \( k = 2 \) (solid). The scatter bound of such a decomposition is \( \delta \simeq 0.075 \). Note that there are several overlapping points at \( \theta = 28^\circ, 103^\circ, 176^\circ, 248.5^\circ, 343.5^\circ \). (b) Superposition of single-wave-number structures giving rise to the crown pattern in Fig. 1(b). still identifiable despite \( \delta \simeq 0.94\lambda \) implies that the condition \( \lambda > 2\delta \) in Theorem 2 is sufficient, but not necessary.
the attempted fit of the data to a single-wave-number pattern in Fig. 13(b) exhibiting the scatter [cf. Fig. 13(c)] substantially larger than the wavelength.

E. A frustrated pattern

Finally, we would like to “decipher” the pattern in Fig. 1(b), which will serve as an illustration of both a superposition of several single-wave-number patterns and overlapping points. Naturally, the DFT and order parameter approaches are not helpful in this case and thus are not discussed. The single-wave-number patterns are identified with the help of the algorithm in the proof of Theorem 3 leading to the plot \( \theta(n) \) in Fig. 14(a); the complete pattern decomposition is shown in Fig. 14(b).

As one can see from the latter figure, there are five overlapping points, which is suggested, in particular, by the larger size of the corresponding spikes in Fig. 1(b). While it may appear that given random initial conditions the odds of five coinciding spikes are very low, the surface tension effect tends to minimize the surface area. Therefore, if there are two close enough spikes and the time evolution of the crown is sufficiently slow, surface tension will have time to force the spikes to merge in a way similar to the coalescence of liquid drops.

V. CONCLUSIONS

In this paper, we offered a theoretical approach for pattern identification in the wave-number space. At its basis is the case of ideal patterns without scatter. The effects of scatter and overlaps are then introduced as a generalization of the ideal pattern identification algorithm; conditions for pattern identification are established systematically. This theoretical approach is applicable to a broad range of physical problems with \( S(1) \) symmetry on spatial and time domains. The case of incomplete patterns remains a challenge, though a step has been taken toward defining such patterns and understanding the conditions under which they are identifiable. Another potentially interesting extension of the pattern identification theory could involve quasipatterns, i.e., patterns that satisfy

\[
 f(x + T) = e^{a + b} f(x) \text{ with quasiperiod } T \text{ and some constants } a \text{ and } b.
\]

To illustrate the theory, an experimental method is developed to produce data suitable for the pattern identification analysis of the crowns resulting from drop splashing. In particular, we used stereo triangulation and a data reduction procedure to identify the angular position of each crown spike, and we applied the theory to a regular pattern with scatter as well as to irregular and frustrated patterns.

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